Search Notes		
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	I ELI I E E I	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/810,324	SCHEIN ET AL.	
Examiner	Art Unit	
Hai Tran	2623	

-	SEAR	CHED	
Class	Subclass	Date	Examiner
725	40,50,60- 61	4/3/2006	HVT

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner

	EARCH STRATEGY DATE	EXMR
East attached	4/3/2006	HVT